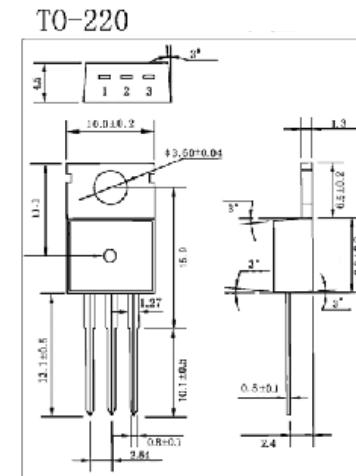


N-Channel Power MOSFET (100V/27A)

GENERAL DESCRIPTION

It uses advanced trench technology and design to provide excellent $R_{DS(on)}$ with low gate charge. This device is suitable for high current load applications.

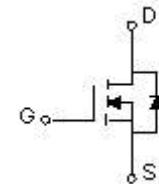


FEATURE

- High current rating
- Ultra lower $R_{DS(on)}$
- Good stability and uniformity with high E_{AS}
- Excellent package for good heat dissipation

APPLICATION

- Power switching application
- Load switching in high circuit application
- DC/DC converters



Maximum ratings ($T_a=25^\circ\text{C}$ unless otherwise noted)

PARAMETER	Symbol	Value	Unit
Drain- Source Voltage	V_{DS}	100	V
Gate- Source Voltage	V_{GS}	± 20	
Continuous Drain Current	I_D	27	A
Pulsed Drain Current	I_{DM}	50	
Single Pulsed Avalanche Energy (note1)	E_{AS}	250	mJ
Thermal Resistance from Junction to Ambient	R_{JA}	62.5	$^\circ\text{C}/\text{W}$
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature Range	T_{STG}	- 55 ~ +150	
Maximum lead temperature for soldering purposes , 1/8" from case for 5 seconds	T_L	260	

Electrical characteristics ($T_a=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Off characteristics						
Drain - source breakdown voltage	$V_{(\text{BR})\text{DSS}}$	$V_{\text{GS}} = 0\text{V}, I_{\text{D}} = 250\mu\text{A}$	100			V
Zero gate voltage drain current	I_{DSS}	$V_{\text{DS}} = 100\text{V}, V_{\text{GS}} = 0\text{V}$			25	μA
Gate - body leakage current	I_{GSS}	$V_{\text{DS}} = 0\text{V}, V_{\text{GS}} = \pm 20\text{V}$			± 100	nA
On characteristics (note2)						
Gate- threshold voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}} = V_{\text{GS}}, I_{\text{D}} = 250\mu\text{A}$	2		4	V
Static drain - source on - resistance	$R_{\text{DS}(\text{on})}$	$V_{\text{GS}} = 10\text{V}, I_{\text{D}} = 16\text{A}$		34	44	$\text{m}\Omega$
Forward transconductance	g_{fs}	$V_{\text{DS}} = 50\text{V}, I_{\text{D}} = 7.5\text{A}$	3.8			S
Dynamic characteristics (note 3)						
Input capacitance	C_{iss}	$V_{\text{DS}} = 25\text{V}, V_{\text{GS}} = 0\text{V}, f = 1\text{MHz}$		800		pF
Output capacitance	C_{oss}			240		
Reverse transfer capacitance	C_{rss}			76		
Switching characteristics (note 3)						
Turn - on delay time	$t_{\text{d}(\text{on})}$	$V_{\text{DD}} = 100\text{V}, V_{\text{GS}} = 10\text{V}, R_{\text{G}} = 12\Omega, I_{\text{D}} = 5.9\text{A}$		9.4		ns
Turn - on rise time	t_{r}			28		
Turn - off delay time	$t_{\text{d}(\text{off})}$			39		
Turn - off fall time	t_{f}			20		
Drain-Source Diode Characteristics						
Drain - source diode forward voltage(note2)	V_{SD}	$V_{\text{GS}} = 0\text{V}, I_{\text{S}} = 14\text{A}$			2	V
Continuous drain - source diode forward current(note4)	I_{S}				9.3	A
Pulsed drain - source diode forward current	I_{SM}				37	A

Notes :

1. $L = 4.6\text{mH}, I_L = 9.9\text{A}, V_{\text{DD}} = 50\text{V}, R_G = 25\Omega$, Starting $T_J = 25^\circ\text{C}$.
2. Pulse Test : Pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.
3. Guaranteed by design,not subject to production
4. Surface mounted on FR4 board, $t \leq 10\text{s}$

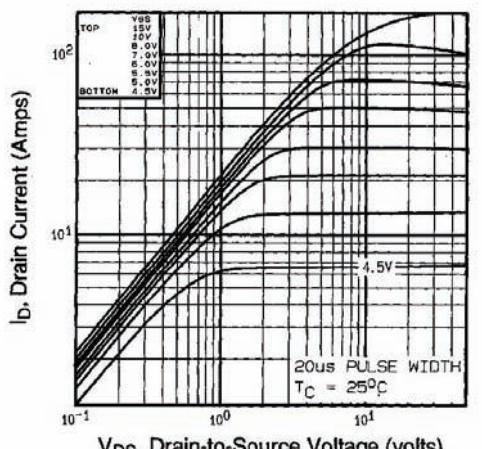
TYPICAL CHARACTERISTICS (Ta=25°C, unless otherwise noted)


Fig. 1 - Typical Output Characteristics, $T_C = 25^\circ\text{C}$

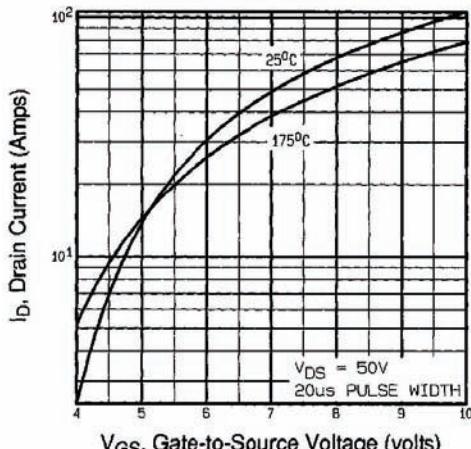


Fig. 3 - Typical Transfer Characteristics

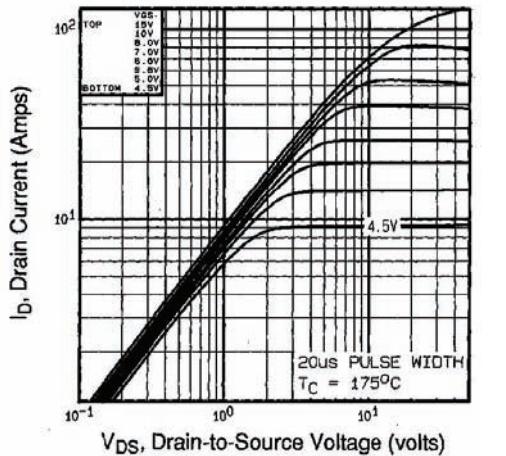


Fig. 2 - Typical Output Characteristics, $T_C = 175^\circ\text{C}$

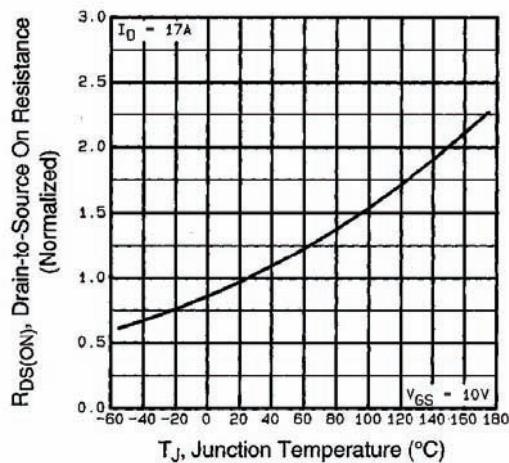


Fig. 4 - Normalized On-Resistance vs. Temperature

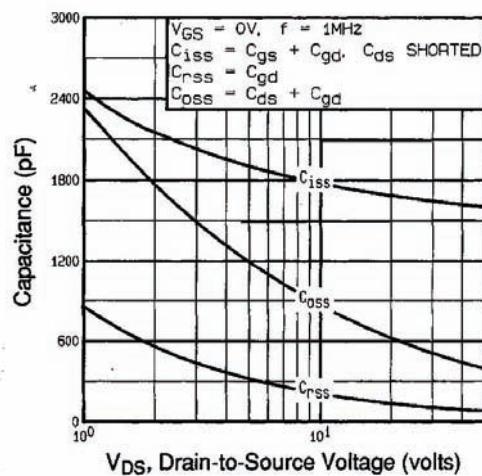


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

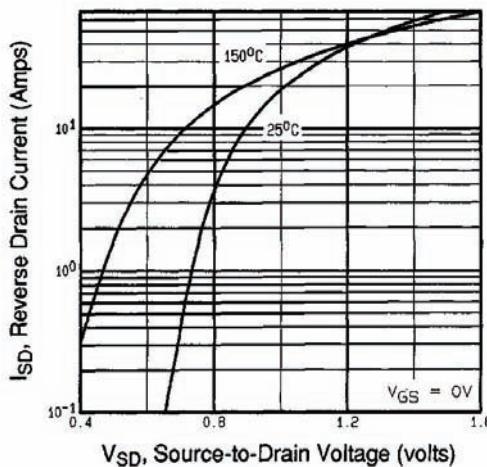


Fig. 7 - Typical Source-Drain Diode Forward Voltage

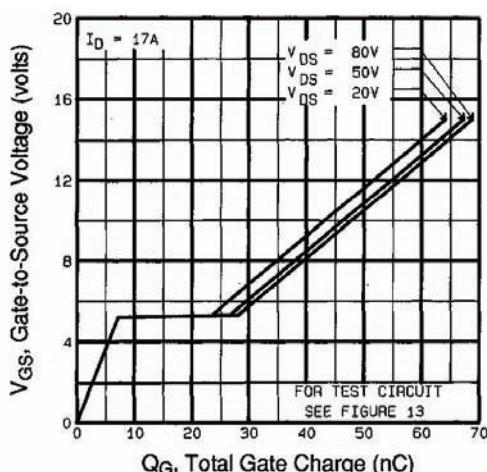


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

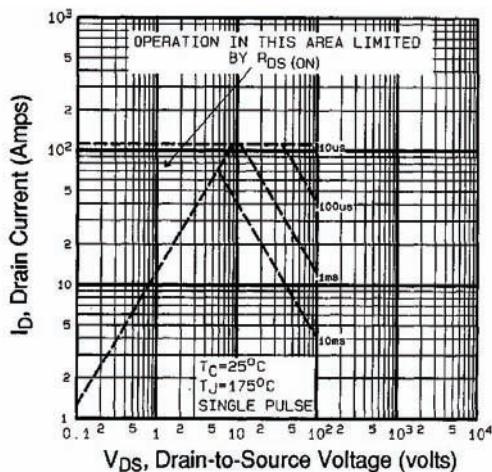


Fig. 8 - Maximum Safe Operating Area

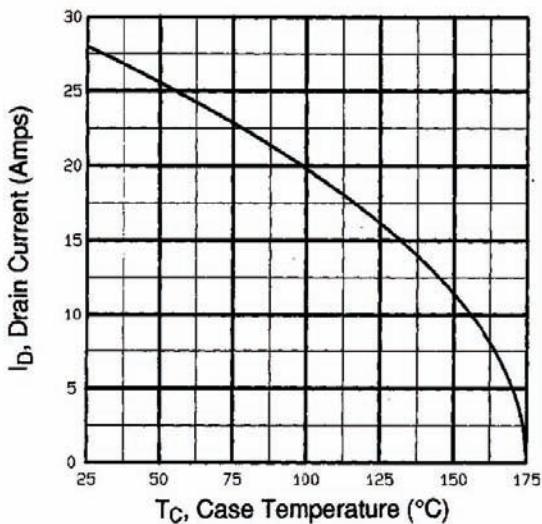


Fig. 9 - Maximum Drain Current vs. Case Temperature

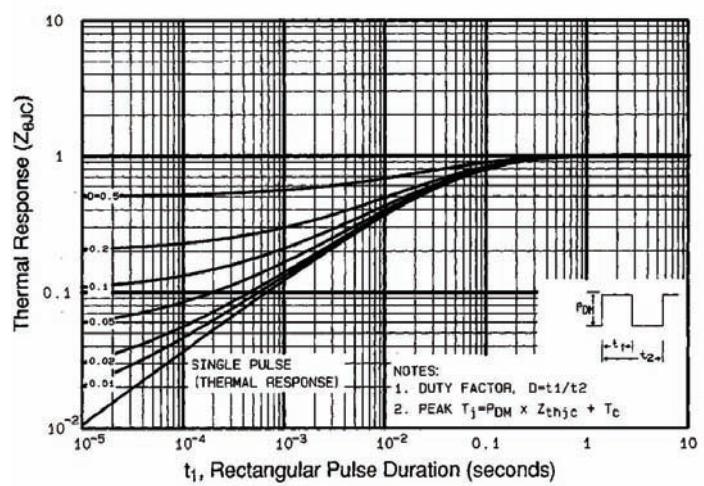


Fig. 10 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

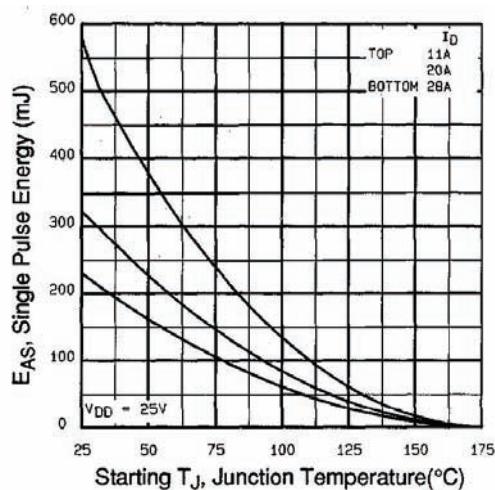


Fig. 11 - Maximum Avalanche Energy vs. Drain Current